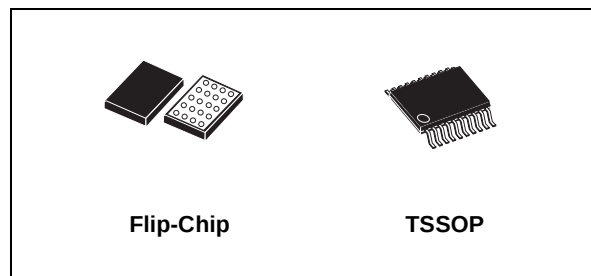


8-BIT DUAL SUPPLY 1.71V TO 5.5V LEVEL TRANSLATOR WITH I/O_{VCC} ±15KV ESD PROTECTION

- **HIGH SPEED:** $t_{PD} = 15\text{ns}$ (MAX.) at $T_A = 85^\circ\text{C}$
 $V_L = 1.8\text{V}$; $V_{CC} = 5.5\text{V}$
- **GUARANTEED DATA RATE:**
13Mbps ($1.8\text{V} \leq V_L \leq V_{CC} \leq 5.5\text{V}$)
- **LOW POWER DISSIPATION:**
 $I_{TS-VL} = I_{TS-VCC} = 1\mu\text{A}$ (MAX.) at $T_A = 85^\circ\text{C}$
 $I_{QVL} = 100\mu\text{A}$ (MAX.) at $T_A = 85^\circ\text{C}$
 $I_{QCC} = 10\mu\text{A}$ (MAX.) at $T_A = 85^\circ\text{C}$
- **OUTPUT IMPEDANCE:**
 $|I_{OHA}| = 20\mu\text{A}$ (MIN.) at $V_L = 1.8\text{V}$ $V_{CC} = 5.5\text{V}$
 $I_{OLA} = 1.0\text{mA}$ (MIN.) at $V_L = 1.8\text{V}$ $V_{CC} = 5.5\text{V}$
- **BIDIRECTIONAL LEVEL TRANSLATION**
- **TOTEM POLE AND OPEN DRAIN DRIVING FOR I²C COMMUNICATIONS**
- **5V TOLERANT ON ENABLE PIN**
- **THERMAL SHORT-CIRCUIT PROTECTION**
- **WIDE OPERATING VOLTAGE RANGE:**
 $V_L(\text{OPR}) = 1.71\text{V to } V_{CC}$
 $V_{CC}(\text{OPR}) = 1.71\text{V to } 5.5\text{V}$
- **ESD PERFORMANCE:**
HBM > 15KV ESD PROTECTION ON I/O_{VCC} LINES
- **LEADFREE FLIPCHIP AND TSSOP PACKAGES**



Externally applied voltages, V_{CC} and V_L , set the logic levels on either side of the device. It utilizes a transmission-gate-based design to allow data translation in either direction ($V_L \leftrightarrow V_{CC}$) on any single data line. The ST2378E accepts V_L from +1.71V to V_{CC} and V_{CC} from +1.71V to +5.5V, making them ideal for data transfer between low-voltage ASICs/PLDs and higher voltage systems. The ST2378E has a three-state output mode that reduces supply current to less than $1\mu\text{A}$, thermal short-circuit protection, and $\pm 15\text{kV}$ ESD protection on the V_{CC} side for greater protection in applications that route signals externally.

The ST2378E operates at a guaranteed data rate of 13Mbps over the entire specified operating voltage range. Within specific voltage domains, higher data rates are possible.

DESCRIPTION

The ST2378E is a $\pm 15\text{kV}$ ESD-protected level translator providing the level shifting necessary to allow data transfer in a multi-voltage system.

Figure 1: Block Diagram

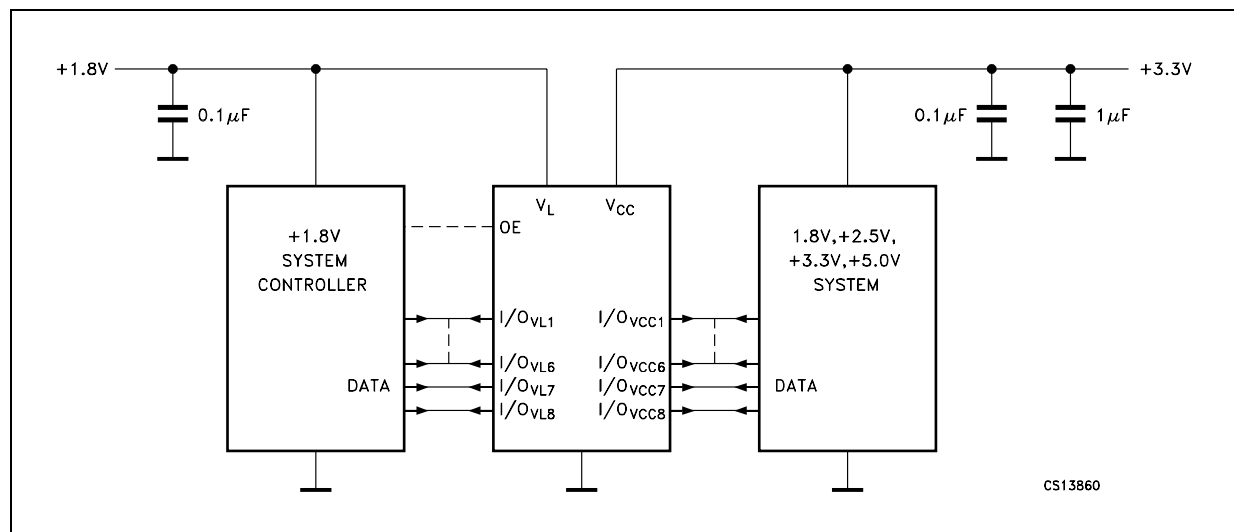


Figure 2: Functional Diagram (1 I/O LINE)

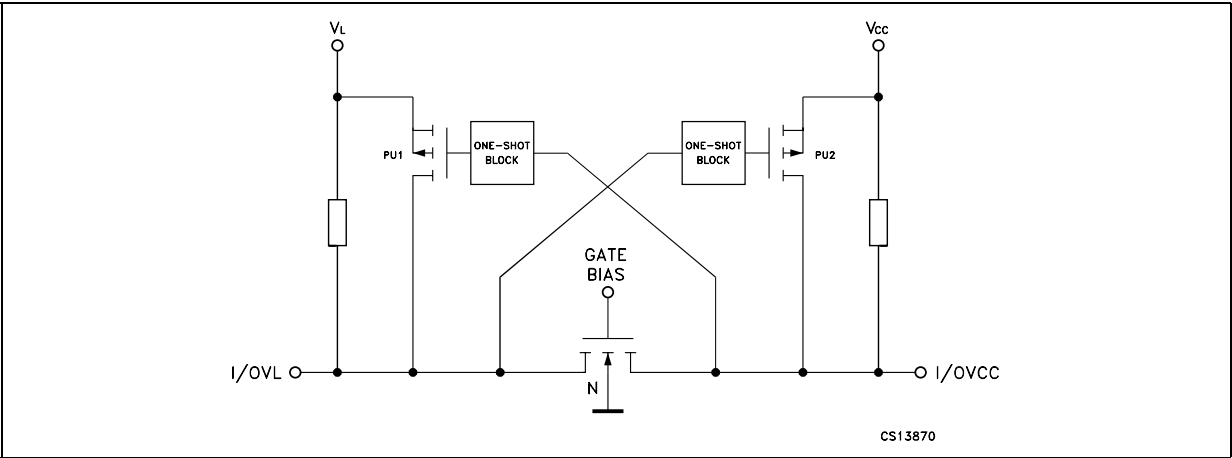


Table 1: Order Codes

Type	Temperature Range	Package	Comments
ST2378EBJR	-40 to 85 °C	Flip-Chip20 (Tape & Reel)	3000 parts per reel
ST2378ETTR	-40 to 85 °C	TSSOP20 (Tape & Reel)	2500 parts per reel

Table 2: Pin Description

FLIPCHIP20 PIN N°	TSSOP20 PIN N°	SYMBOL	NAME AND FUNCTION
E2, D1, D2, C1, C2, B1, B2, A1	2, 18, 4, 16, 6, 14, 8, 12	I/O _{VL1} to I/O _{VL8}	Data Inputs/Outputs
E3, D4, D3, C4, C3, B4, B3, A4	19, 3, 17, 5, 15, 7, 13, 9	I/O _{VCC1} to I/O _{VCC8}	Data Inputs/Outputs
A2	11	OE	Output Enable Inputs
A3	10	GND	Ground (0V)
E1	1	V _L	Positive Supply Voltage
E4	20	V _{CC}	Positive Supply Voltage

PIN CONFIGURATION

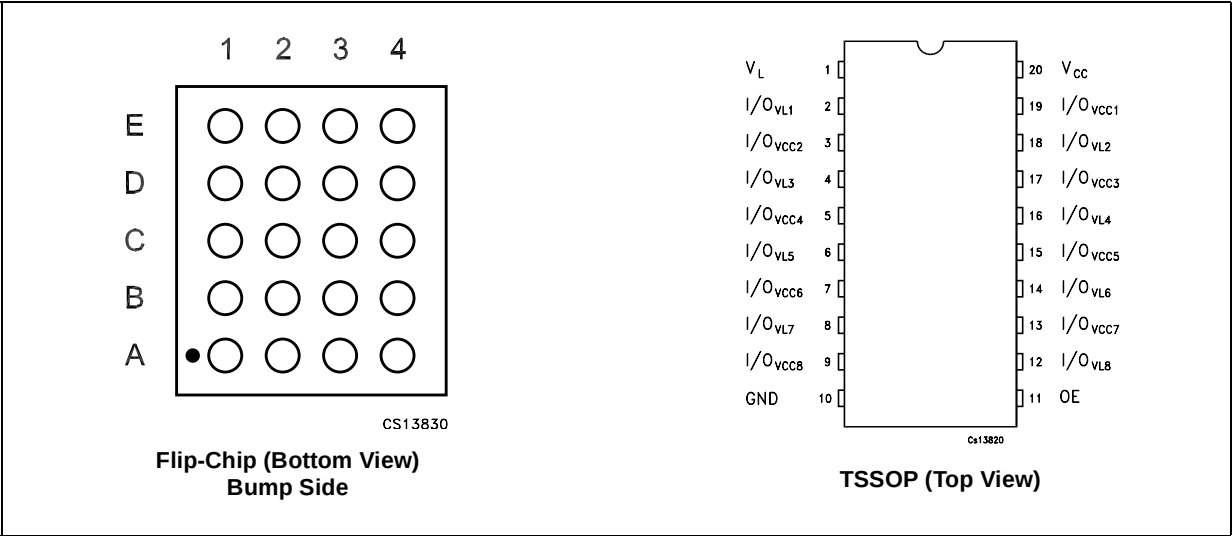


Table 3: Truth Table

Control Pin	Bidirectional Input/Outputs		Thermal Protection
	I/O _{VL}	I/O _{VCC}	
OE			
H ⁽¹⁾	H ⁽¹⁾	H ⁽²⁾	Enabled
H ⁽¹⁾	L	L	Enabled
L	Z	Z	Disabled ⁽³⁾

X=Don't care; Z=High Impedance;

1) High Level V_L Power Supply referred

2) High Level V_{CC} Power Supply referred

3) Thermal Protection disabled reduces the quiescent current consumption I_{TS-VCC}=I_{TS-VL}= 1μA Max at 85°C

Table 4: Absolute Maximum Ratings

Symbol	Parameter	Value	Unit
V _L	Supply Voltage	-0.3 to V _{CC}	V
V _{CC}	Supply Voltage	-0.3 to +7.0	V
V _{OE}	DC Control Input Voltage	-0.3 to +7.0	V
V _{I/OVL}	DC I/O _{VL} Input Voltage (OE = Gnd or V _L)	-0.3 to V _L + 0.3	V
V _{I/OVCC}	DC I/O _{VCC} Input Voltage (OE = Gnd or V _L)	-0.3 to V _{CC} + 0.3	V
I _{IK}	DC Input Diode Current (OE Control Pin)	- 20	mA
I _{IOVL}	DC Output Current	± 25	mA
I _{IOVCC}	DC Output Current	± 25	mA
I _{SCOUT}	Short Circuit Duration I/O _{VL} , I/O _{VCC} Driven from 40mA Source	Continuous	mA
I _{CCB}	DC V _{CC} or Ground Current	± 100	mA
P _d	Power Dissipation(*)	500	mW
T _{stg}	Storage Temperature	-65 to +150	°C
T _L	Lead Temperature (10 sec)	300	°C

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied

(*) 500mW: ≡ 65°C derated to 300mW by 10mW/°C: 65°C to 85°C

Table 5: Recommended Operating Conditions

Symbol	Parameter		Value	Unit
V _L	Supply Voltage		1.71 to V _{CC}	V
V _{CC}	Supply Voltage		1.71 to 5.5	V
V _I	Input Voltage (OE Output Enable Pin, V _L Power Supply referred)		0 to 5.5	V
V _{I/OVL}	I/O _{VL} Voltage		0 to V _L	V
V _{I/OVCC}	I/O _{VCC} Voltage		0 to V _{CC}	V
T _{op}	Operating Temperature		-40 to 85	°C
dt/dv	Input Rise and Fall Time (OE Control Pin) ⁽¹⁾		0 to 10	ns/V
dt/dv	Input Rise and Fall Time (2)	1.71 < V _L < V _{CC} < 5V	0 to 10	ns/V
		V _{CC} = V _L = 5V	0 to 3	ns/V

1) V_{OE} from 10% V_L to 90%V_L

2) V_{IOVL} from 10%V_L to 90%V_L; V_{IOVCC} from 10%V_{CC} to 90%V_{CC}

Table 6: DC Specification

Symbol	Parameter	Test Condition			Value					Unit
		V _L (*) (V)	V _{CC} (*) (V)		T _A = 25 °C			-40 to 85 °C		
					Min.	Typ	Max.	Min.	Max.	
V _{IHL}	High Level Input Voltage (I/O _{VL})	1.8	V _L to 5.5		V _L -0.2			V _L -0.2		V
		2.5	V _L to 5.5		0.75V _L			0.75V _L		
		3.3	V _L to 5.5		0.75V _L			0.75V _L		
		5.0	V _L to 5.5		0.75V _L			0.75V _L		
V _{ILL}	Low Level Input Voltage (I/O _{VL})	1.8	V _L to 5.5				0.15		0.15	V
		2.5	V _L to 5.5				0.30		0.30	
		3.3	V _L to 5.5				0.30		0.30	
		5.0	V _L to 5.5				0.30		0.30	
V _{IHC}	High Level Input Voltage (I/O _{VCC})	1.8	V _L to 5.5		V _L -0.2			V _L -0.2		V
		2.5	V _L to 5.5		0.75V _{CC}			0.75V _{CC}		
		3.3	V _L to 5.5		0.75V _{CC}			0.75V _{CC}		
		5.0	V _L to 5.5		0.75V _{CC}			0.75V _{CC}		
V _{ILC}	Low Level Input Voltage (I/O _{VCC})	1.8	V _L to 5.5				0.15		0.15	V
		2.5	V _L to 5.5				0.30		0.30	
		3.3	V _L to 5.5				0.30		0.30	
		5.0	V _L to 5.5				0.30		0.30	
V _{IH-TS}	High Level Input Voltage (OE)	1.8	V _L to 5.5		V _L -0.2			V _L -0.2		V
		2.5	V _L to 5.5		0.75V _L			0.75V _L		
		3.3	V _L to 5.5		0.75V _L			0.75V _L		
		5.0	V _L to 5.5		0.75V _L			0.75V _L		
V _{IL-TS}	Low Level Input Voltage (OE)	1.8	V _L to 5.5				0.15		0.15	V
		2.5	V _L to 5.5				0.25V _L		0.25V _L	
		3.3	V _L to 5.5				0.25V _L		0.25V _L	
		5.0	V _L to 5.5				0.25V _L		0.25V _L	
V _{OHL}	High Level Output Voltage I/O _{VL}	1.8 to 5.5	V _L to 5.5	I _O =-20 μA I/O _{VCC} ≥V _{CC} -0.2	0.67V _L			0.67V _L		V
V _{OLL}	Low Level Output Voltage I/O _{VL}			I _O =1.0 mA I/O _{VCC} ≤0.15V			0.40		0.40	
V _{OHC}	High Level Output Voltage I/O _{VCC}	1.8 to 5.5	V _L to 5.5	I _O =-20 μA I/O _{VL} ≥V _L -0.2	0.67V _{CC}			0.67V _{CC}		V
V _{OLC}	Low Level Output Voltage I/O _{VCC}			I _O =1.0 mA I/O _{VL} ≤0.15V			0.40		0.40	
I _{TSL}	Control Input Leakage Current (OE)	1.8 to 5.5	V _L to 5.5	V _I =GNDor5.5			1		1	μA
I _{TS-LKG}	High Impedance Input Leakage Current (I/O _{VL} , I/O _{VCC})	1.8 to 5.5	V _L to 5.5	OE = GND			1		1	μA
I _{QVCC}	Quiescent Supply Current V _{CC}	1.8 to 5.5	V _L to 5.5	I/O _{VL} , I/O _{VCC} unconnected		0.1	1		10	μA
I _{QVL}	Quiescent Supply Current V _L	1.8 to 5.5	V _L to 5.5	I/O _{VL} , I/O _{VCC} unconnected		13	20		100	μA

Symbol	Parameter	Test Condition			Value					Unit
		V _L ^(*) (V)	V _{CC} ^(*) (V)		T _A = 25 °C			-40 to 85 °C		
					Min.	Typ	Max.	Min.	Max.	
I _{TS-VCC}	High Impedance Mode Quiescent Supply Current V _{CC}	1.8 to 5.5	V _L to 5.5	OE= GND			1		1	μA
I _{TS-VL}	High Impedance Mode Quiescent Supply Current V _L	1.8 to 5.5	V _L to 5.5	OE= GND I/O _{V_L} = GND or V _L I/O _{V_{CC}} = GND or V _{CC}			1		1	μA

1) Typical values are referred to $T_A=25^{\circ}\text{C}$

2) Power Supply Range: V_L, V_{CC} 1.8V $\pm$ 5%, 2.5 $\pm$ 0.2V, 3.3 $\pm$ 0.3V, 5.0 $\pm$ 0.5V

5) For normal operation, ensure $V_L < (V_{CC} + 0.3\text{V})$. During power-up, $V_L > (V_{CC} + 0.3\text{V})$ will not damage the device

Table 7: AC Electrical Characteristics

Symbol	Parameter		Test Condition ⁽⁵⁾		Value			Unit	
			C _L =15pF t _r =t _f ≤ 6ns Driver output R _T ≤ 50Ω ⁽⁸⁾		-40 to +85 °C				
			V _L (V) ⁽²⁾	V _{CC} (V) ⁽²⁾	Min.	Typ. ⁽¹⁾	Max.		
t _{RVCC}	Rise Time I/O _{VCC} ⁽³⁾⁽⁸⁾		1.8	1.8		11	15	ns	
			1.8	5.0		9	15		
t _{FVCC}	Fall Time I/O _{VCC} ⁽³⁾		1.8	1.8		6	15	ns	
			1.8	5.0		10	15		
t _{RVL}	Rise Time I/O _{VL} ⁽³⁾		1.8	1.8		12	15	ns	
			1.8	5.0		10	15		
t _{FVL}	Fall Time I/O _{VL} ⁽³⁾		1.8	1.8		7	15	ns	
			1.8	5.0		7	15		
t _{IOVL-VCC}	Propagation Delay Time ⁽⁴⁾ I/O _{VL-LH} to I/O _{VCC-LH} I/O _{VL-HL} to I/O _{VCC-HL}		t _{PLH}	1.8	1.8		6	15	ns
				1.8	5.0		7	15	
			t _{PHL}	1.8	1.8		5	15	
				1.8	5.0		8	15	
t _{IOVCC-VL}	Propagation Delay Time ⁽⁴⁾ I/O _{VCC-LH} to I/O _{VL-LH} I/O _{VCC-HL} to I/O _{VL-HL}		t _{PLH}	1.8	1.8		2	15	ns
				1.8	5.0		2	15	
			t _{PHL}	1.8	1.8		5	15	
				1.8	5.0		6	15	
t _{PZL} t _{PZH} t _{PLZ} t _{PHZ}	Output Enable and Disable Time		1.8	1.8		38	60	ns	
			1.8	5.0		44	60		
D _R	Maximum Data Rate		1.8	1.8	13			Mbps	
			1.8	5.0	13				
t _{OSLH} t _{OSHL}	Channel to Channel Skew Time (note 6, 7)		1.8	1.8		0.1	1	ns	
			1.8	5.0		0.5	1	ns	

1) Typical values are referred to $T_A=25^{\circ}\text{C}$

2) Power Supply Range: V_L, V_{CC} 1.8V $\pm$ 5%, 2.5 $\pm$ 0.2V, 3.3 $\pm$ 0.3V, 5.0 $\pm$ 0.5V.

3) Rise Time:10% to 90%, Fall Time 90% to 10%

4) tpd: 50% to 50%

5) For normal operation, ensure $V_L < (V_{CC} + 0.3\text{V})$. During power-up, $V_L > (V_{CC} + 0.3\text{V})$ will not damage the device

6) Skew is defined as the absolute value of the difference between the actual propagation delay for any two outputs of the same device switching in the same direction, either HIGH or LOW ($t_{OSLH} = |t_{PLHm} - t_{PLHn}|$, $t_{OSHL} = |t_{PHLm} - t_{PHLn}|$)

7) Each translator equally loaded; parameter guaranteed by design

8) For $V_{CC} = V_L = 1.8\text{V}$, $t_r = t_f \leq 4\text{ns}$

Table 8: AC Electrical Characteristics

Symbol	Parameter		Test Condition ⁽⁵⁾		Value			Unit	
			C _L =15pF t _r =t _f ≤ 6ns Driver output R _T ≤ 50Ω		-40 to +85 °C				
			V _L (V) ⁽²⁾	V _{CC} (V) ⁽²⁾	Min.	Typ. ⁽¹⁾	Max.		
t _{RVCC}	Rise Time I/O _{VCC} ⁽³⁾		1.8	2.5		11	15	ns	
			1.8	3.3		10	15		
			2.5	3.3		8	15		
t _{FVCC}	Fall Time I/O _{VCC} ⁽³⁾		1.8	2.5		7	15	ns	
			1.8	3.3		8	15		
			2.5	3.3		6	15		
t _{RVL}	Rise Time I/O _{VL} ⁽³⁾		1.8	2.5		10	15	ns	
			1.8	3.3		9	15		
			2.5	3.3		7	15		
t _{FVL}	Fall Time I/O _{VL} ⁽³⁾		1.8	2.5		6	15	ns	
			1.8	3.3		6	15		
			2.5	3.3		4	15		
t _{IOVL-VCC}	Propagation Delay Time ⁽⁴⁾ I/O _{VL-LH} to I/O _{VCC-LH} I/O _{VL-HL} to I/O _{VCC-HL}		t _{PLH}	1.8	2.5		7	15	ns
				1.8	3.3		7	15	
				2.5	3.3		4	15	
			t _{PHL}	1.8	2.5		5	15	
				1.8	3.3		6	15	
				2.5	3.3		4	15	
t _{IOVCC-VL}	Propagation Delay Time ⁽⁴⁾ I/O _{VCC-LH} to I/O _{VL-LH} I/O _{VCC-HL} to I/O _{VL-HL}		t _{PLH}	1.8	2.5		2	15	ns
				1.8	3.3		2	15	
				2.5	3.3		2	15	
			t _{PHL}	1.8	2.5		5	15	
				1.8	3.3		5	15	
				2.5	3.3		4	15	
t _{PZL} t _{PZH} t _{PLZ} t _{PHZ}	Output Enable and Disable Time		1.8	2.5		38	60	ns	
			1.8	3.3		38	60		
			2.5	3.3		23	40		
D _R	Maximum Data Rate		1.8	2.5	13			Mbps	
			1.8	3.3	13				
			2.5	3.3	13				

1) Typical values are referred to $T_A=25^\circ\text{C}$ 2) Power Supply Range: V_L , V_{CC} 1.8V $\pm$ 5%, 2.5 $\pm$ 0.2V, 3.3 $\pm$ 0.3V, 5.0 $\pm$ 0.5V.

3) Rise Time:10% to 90%, Fall Time 90% to 10%

4) tpd: 50% to 50%

5) For normal operation, ensure $V_L < (V_{CC} + 0.3\text{V})$. During power-up, $V_L > (V_{CC} + 0.3\text{V})$ will not damage the device6) Skew is defined as the absolute value of the difference between the actual propagation delay for any two outputs of the same device switching in the same direction, either HIGH or LOW ($t_{OSLH} = |t_{PLHm} - t_{PLHn}|$, $t_{OSHL} = |t_{PHLm} - t_{PHLn}|$)

7) Each translator equally loaded; parameter guaranteed by design

Table 9: AC Electrical Characteristics - Open-drain Driving

Symbol	Parameter		Test Condition ⁽⁵⁾		Value			Unit
			C _L =15pF Driver output R _T ≤ 50Ω		-40 to +85 °C			
			V _L (V) ⁽²⁾	V _{CC} (V) ⁽²⁾	Min.	Typ. ⁽¹⁾	Max.	
t _{RVCC}	Rise Time I/O _{VCC} ⁽³⁾		1.8	1.8		210	300	ns
			1.8	5.0		59	150	
t _{FVCC}	Fall Time I/O _{VCC} ⁽³⁾		1.8	1.8		12	30	ns
			1.8	5.0		20	30	
t _{RVL}	Rise Time I/O _{VL} ⁽³⁾		1.8	1.8		210	300	ns
			1.8	5.0		96	150	
t _{FVL}	Fall Time I/O _{VL} ⁽³⁾		1.8	1.8		11	30	ns
			1.8	5.0		11	30	
t _{IOVL-VCC}	Propagation Delay Time ⁽⁴⁾ I/O _{VL-LH} to I/O _{VCC-LH} I/O _{VL-HL} to I/O _{VCC-HL}	t _{PLH}	1.8	1.8		210	300	ns
			1.8	5.0		100	150	
		t _{PHL}	1.8	1.8		7	20	
			1.8	5.0		14	20	
t _{IOVCC-VL}	Propagation Delay Time ⁽⁴⁾ I/O _{VCC-LH} to I/O _{VL-LH} I/O _{VCC-HL} to I/O _{VL-HL}	t _{PLH}	1.8	1.8		210	300	ns
			1.8	5.0		57	150	
		t _{PHL}	1.8	1.8		7	20	
			1.8	5.0		8	20	
D _R	Maximum Data Rate		1.8	1.8	800			Kbps
			1.8	5.0	800			
t _{OSLH}	Channel to Channel Skew Time (note 6, 7)		1.8	1.8		10	20	ns
t _{OSHL}			1.8	5.0		2	10	ns

1) Typical values are referred to T_A=25°C2) Power Supply Range: V_L, V_{CC} 1.8V±5%, 2.5±0.2V, 3.3±0.3V, 5.0±0.5V.

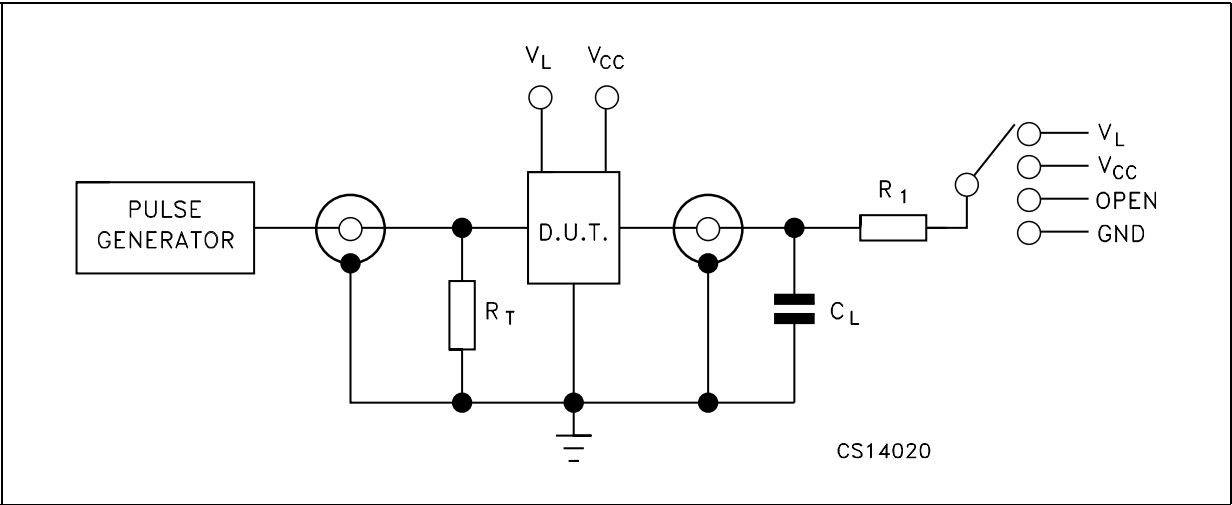
3) Rise Time:10% to 90%, Fall Time 90% to 10%

4) tpd: 50% to 50%

5) For normal operation, ensure V_L < (V_{CC} + 0.3V). During power-up, V_L > (V_{CC} + 0.3V) will not damage the device6) Skew is defined as the absolute value of the difference between the actual propagation delay for any two outputs of the same device switching in the same direction, either HIGH or LOW (t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)

7) Each translator equally loaded; parameter guaranteed by design

Figure 3: Test Circuit

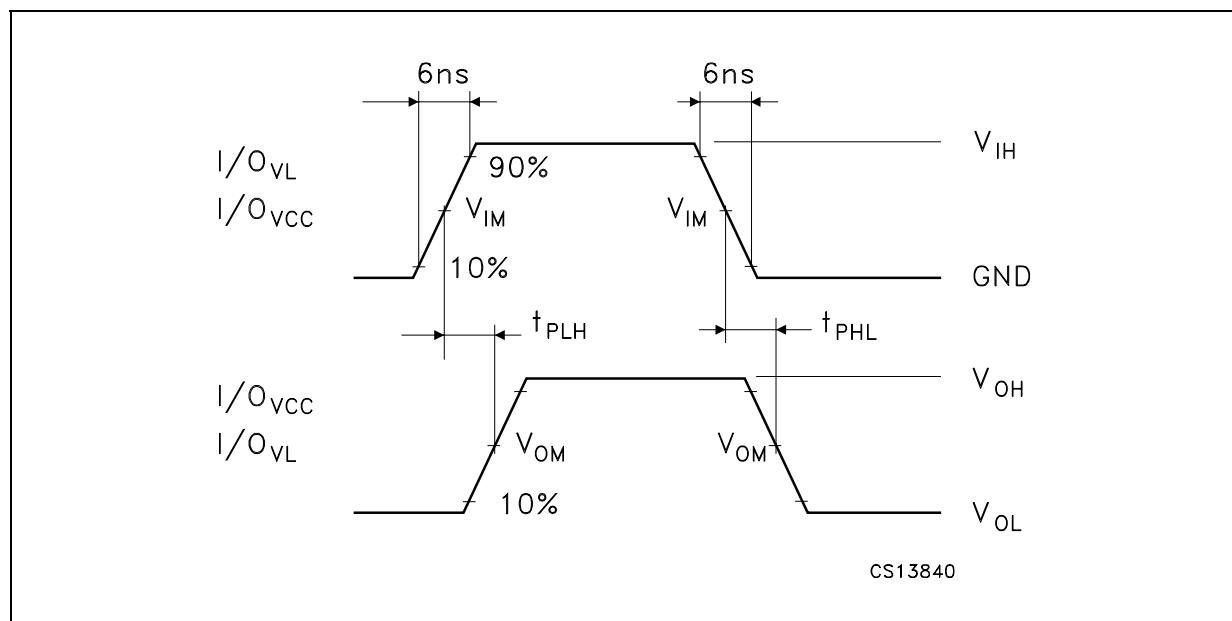
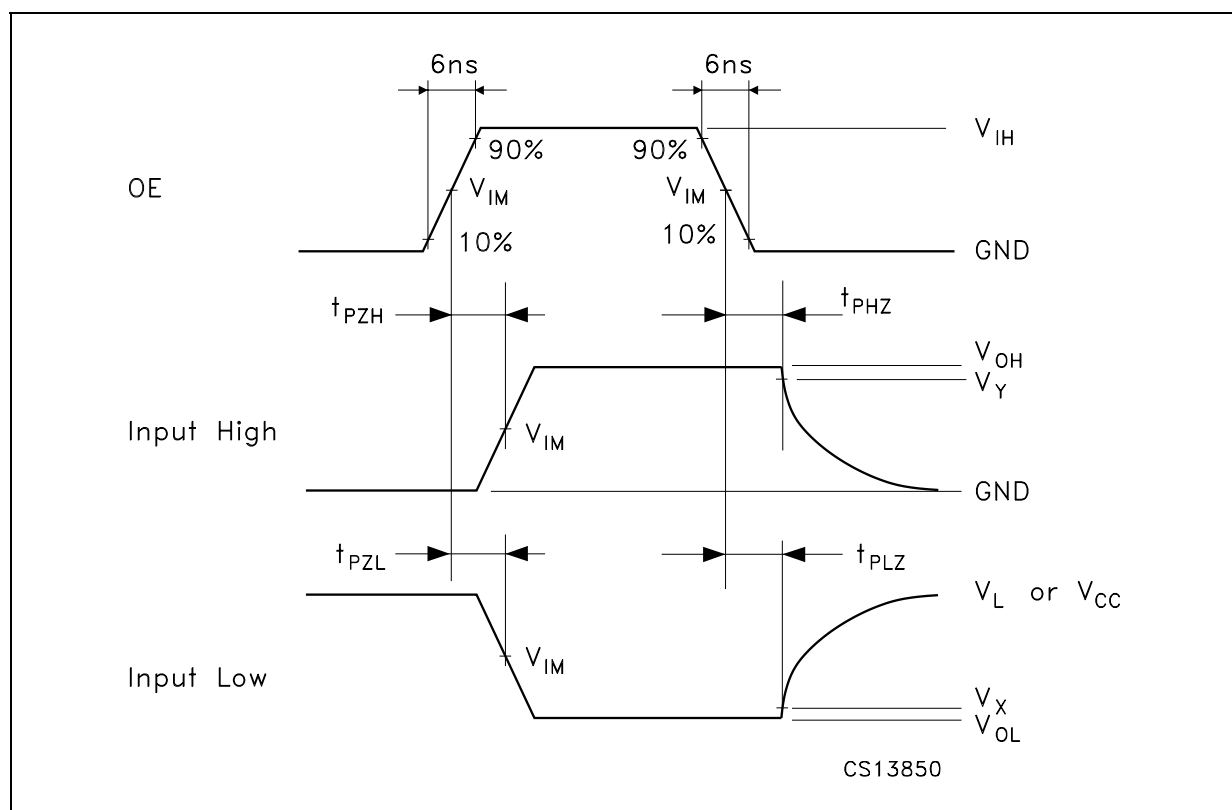


TEST	Switch		
	Driving I/O _{V_L}	Driving I/O _{V_{CC}}	Open Drain Driving
t_{PLH}, t_{PHL}	Open	Open	Open
t_{PZL}, t_{PLZ}	V_{CC}	V_L	-
t_{PZH}, t_{PHZ}	Gnd	Gnd	-

C_L = 15/50pF or equivalent (includes jig and probe capacitance)
 R_1 = 1K Ω or equivalent
 R_T = Z_{OUT} of pulse generator (typically 50 Ω)

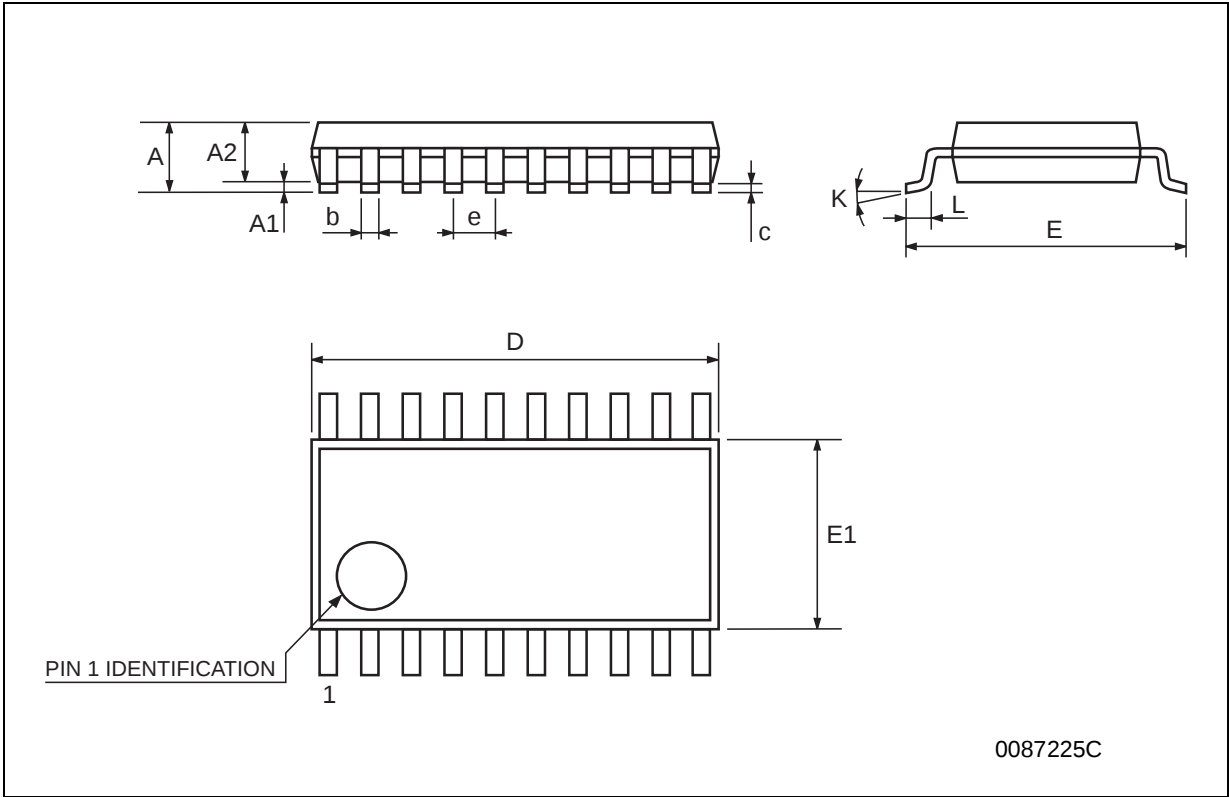
Table 10: Waveform Symbol Value

Symbol	Driving I/O _{V_L}		Driving I/O _{V_{CC}}	
	$1.8V \leq V_L \leq V_{CC} \leq 2.5V$	$3.3V \leq V_L \leq V_{CC} \leq 5.0V$	$1.8V \leq V_L \leq V_{CC} \leq 2.5V$	$3.3V \leq V_L \leq V_{CC} \leq 5.0V$
V_{IH}	V_L	V_L	V_{CC}	V_{CC}
V_{IM}	50% V_L	50% V_L	50% V_{CC}	50% V_{CC}
V_{OM}	50% V_{CC}	50% V_{CC}	50% V_{CC}	50% V_{CC}
V_X	$V_{OL} + 0.15V$	$V_{OL} + 0.3V$	$V_{OL} + 0.15V$	$V_{OL} + 0.3V$
V_Y	$V_{OH} - 0.15V$	$V_{OH} - 0.3V$	$V_{OH} - 0.15V$	$V_{OH} - 0.3V$

Figure 4: Waveform - Propagation Delay ($f=1\text{MHz}$; 50% duty cycle)Figure 5: Waveform - Output Enable And Disable Time ($f=1\text{MHz}$; 50% duty cycle)

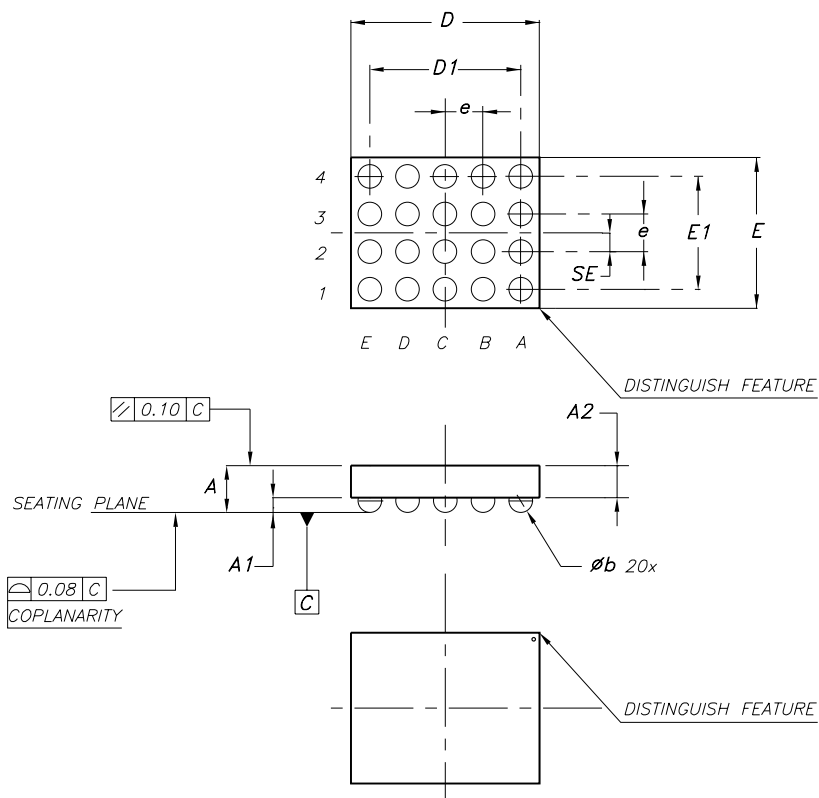
TSSOP20 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A			1.2			0.047
A1	0.05		0.15	0.002	0.004	0.006
A2	0.8	1	1.05	0.031	0.039	0.041
b	0.19		0.30	0.007		0.012
c	0.09		0.20	0.004		0.0079
D	6.4	6.5	6.6	0.252	0.256	0.260
E	6.2	6.4	6.6	0.244	0.252	0.260
E1	4.3	4.4	4.48	0.169	0.173	0.176
e		0.65 BSC			0.0256 BSC	
K	0°		8°	0°		8°
L	0.45	0.60	0.75	0.018	0.024	0.030



Flip-Chip20 MECHANICAL DATA

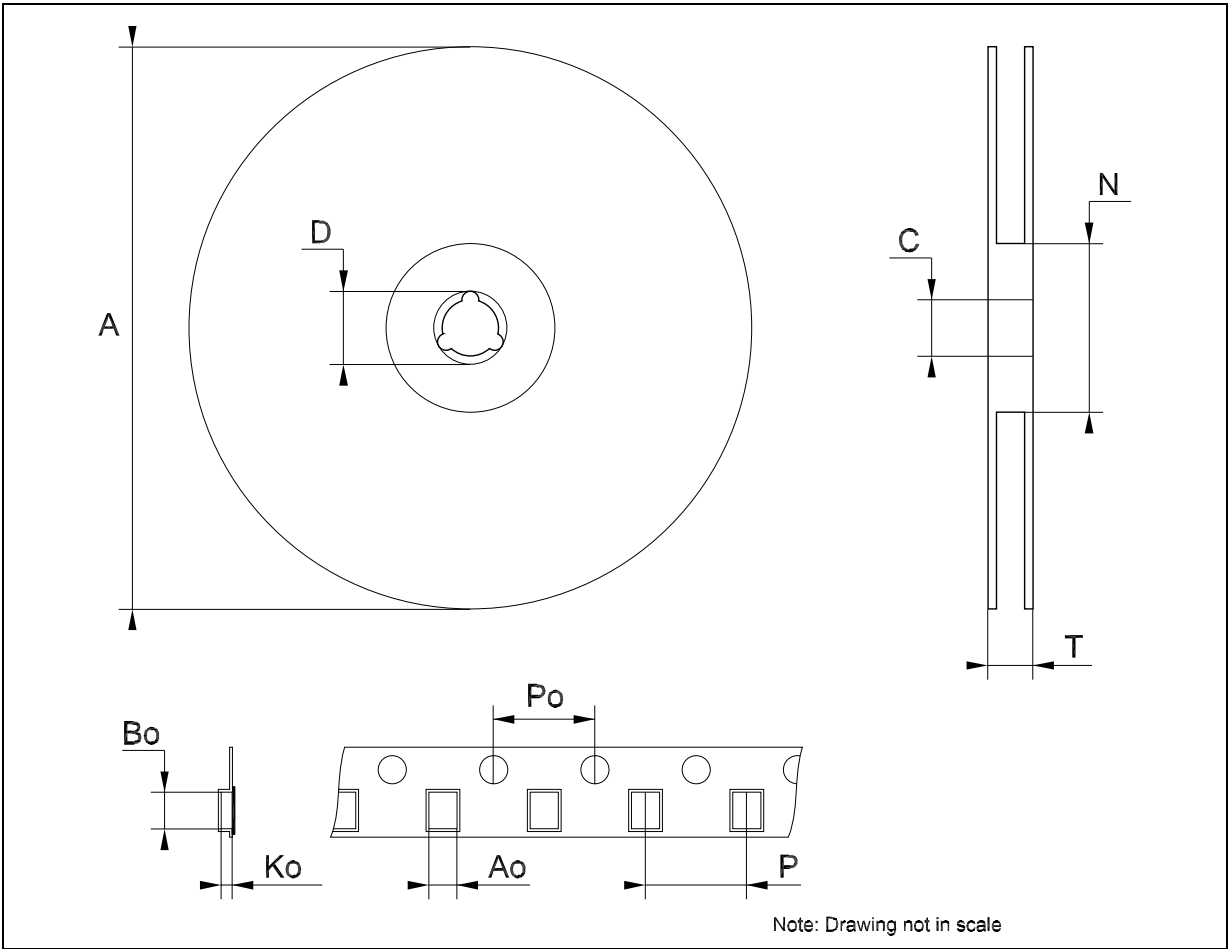
DIM.	mm.			mils		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A	0.81	0.89	1.00	31.9	35.0	39.4
A1	0.15	0.24	0.35	5.9	9.4	13.8
A2		0.65			25.6	
b	0.25	0.30	0.35	9.8	11.8	13.8
D	2.41	2.46	2.51	94.9	96.9	98.8
D1		2.00			78.7	
E	1.93	1.98	2.03	76.0	78.0	79.9
E1		1.5			59.1	
e		0.50			19.7	
SE		0.25			9.8	



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Tape & Reel Flip-Chip20 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A			180			7.086
C	12.8		13.2	0.504		0.519
D	20.2			0.795		
N	60			2.362		
T			14.4			0.567
Ao	2.13	2.23	2.33	0.084	0.088	0.092
Bo	2.62	2.72	2.82	0.103	0.107	0.111
Ko	1.05	1.15	1.25	0.041	0.045	0.049
Po	3.9		4.1	0.153		0.161
P	3.9		4.1	0.153		0.161



Tape & Reel TSSOP20 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A			330			12.992
C	12.8		13.2	0.504		0.519
D	20.2			0.795		
N	60			2.362		
T			22.4			0.882
Ao	6.8		7	0.268		0.276
Bo	6.9		7.1	0.272		0.280
Ko	1.7		1.9	0.067		0.075
Po	3.9		4.1	0.153		0.161
P	11.9		12.1	0.468		0.476

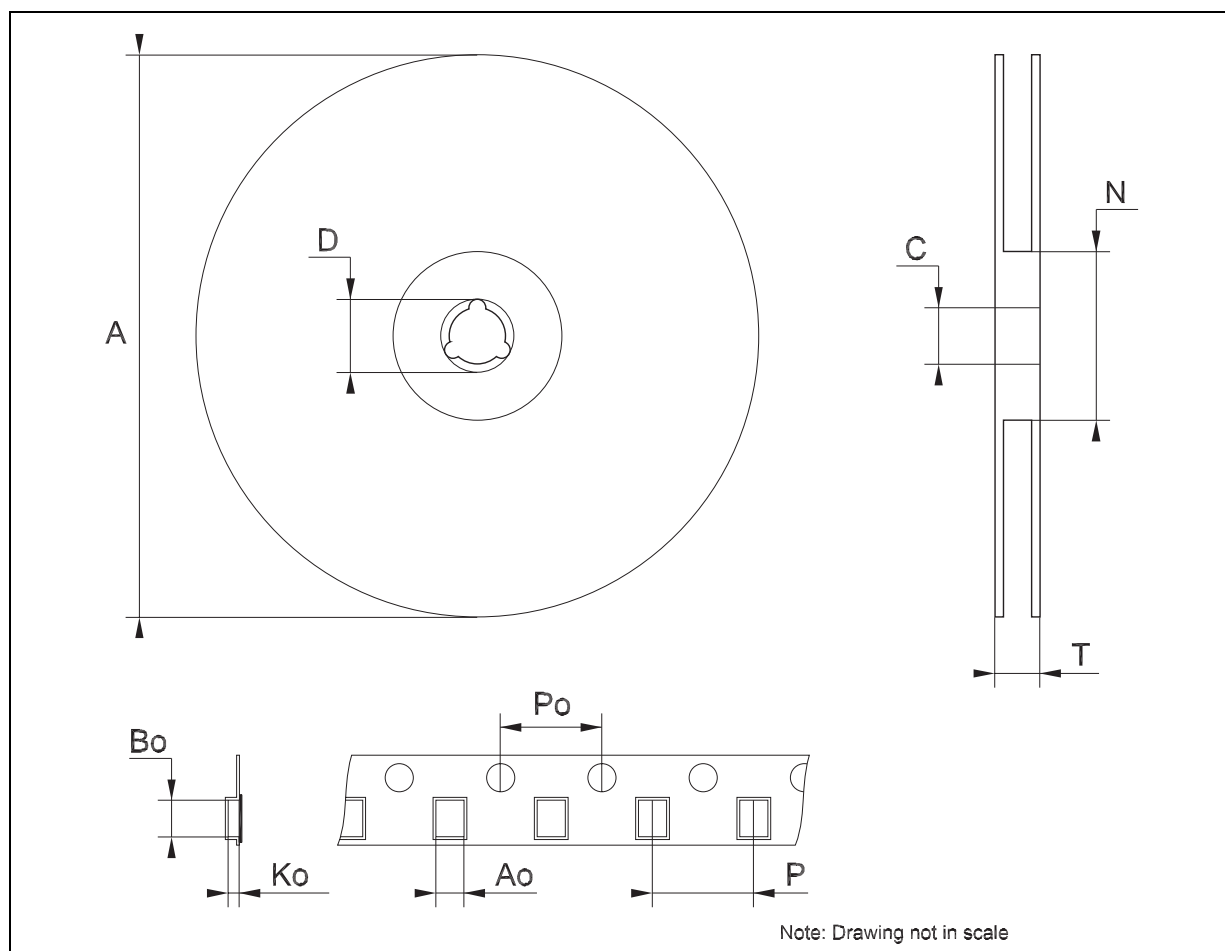


Table 11: Revision History

Date	Revision	Description of Changes
11-Mar-2005	5	Flip-Chip20 Mechanical Data: New Release.

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